

International **IR** Rectifier

HEXFET® POWER MOSFET **THRU-HOLE (TO-257AA)**

PD - 94349A

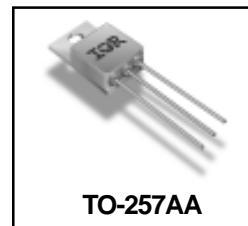
IRF5Y31N20
200V, N-CHANNEL

Product Summary

Part Number	BVDSS	RDS(on)	Id
IRF5Y31N20	200V	0.092Ω	18A*

Fifth Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon unit area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

These devices are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high-energy pulse circuits.



Features:

- Low RDS(on)
- Avalanche Energy Ratings
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Light Weight

Absolute Maximum Ratings

Parameter	Value	Units	
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	A	18*
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current		14
IDM	Pulsed Drain Current ①		72
PD @ TC = 25°C	Max. Power Dissipation	W	100
	Linear Derating Factor	W/°C	0.8
VGS	Gate-to-Source Voltage	V	±20
EAS	Single Pulse Avalanche Energy ②	mJ	170
IAR	Avalanche Current ①	A	18
EAR	Repetitive Avalanche Energy ①	mJ	10
dv/dt	Peak Diode Recovery dv/dt ③	V/ns	1.7
TJ	Operating Junction	°C	-55 to 150
TSTG	Storage Temperature Range		
	Lead Temperature		300 (0.063in./1.6mm from case for 10s)
	Weight	g	4.3 (Typical)

* Current is limited by package

For footnotes refer to the last page

IRF5Y31N20

International
 Rectifier

Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (Unless Otherwise Specified)

	Parameter	Min	Typ	Max	Units	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	200	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	Temperature Coefficient of Breakdown Voltage	—	0.27	—	$\text{V}/^\circ\text{C}$	Reference to 25°C , $\text{I}_D = 1.0\text{mA}$
$\text{R}_{\text{DS(on)}}$	Static Drain-to-Source On-State Resistance	—	—	0.092	Ω	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 14\text{A}$ ④
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	3.0	—	5.5	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	14	—	—	$\text{S} (\text{t})$	$\text{V}_{\text{DS}} = 15\text{V}, \text{I}_{\text{DS}} = 14\text{A}$ ④
I_{DSS}	Zero Gate Voltage Drain Current	—	—	25	μA	$\text{V}_{\text{DS}} = 200\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
		—	—	250		$\text{V}_{\text{DS}} = 160\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_j = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Leakage Forward	—	—	100	nA	$\text{V}_{\text{GS}} = 20\text{V}$
I_{GSS}	Gate-to-Source Leakage Reverse	—	—	-100		$\text{V}_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge	—	—	100	nC	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 18\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	32		$\text{V}_{\text{DS}} = 160\text{V}$
Q_{gd}	Gate-to-Drain ('Miller') Charge	—	—	46		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	—	30	ns	$\text{V}_{\text{DD}} = 100\text{V}, \text{I}_D = 18\text{A}, \text{V}_{\text{GS}} = 10\text{V}, \text{R}_G = 2.5\Omega$
t_r	Rise Time	—	—	148		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	—	50		
t_f	Fall Time	—	—	27		
$L_S + L_D$	Total Inductance	—	6.8	—	nH	Measured from drain lead (6mm / 0.25in. from package) to source lead (6mm/0.25in. from package)
C_{iss}	Input Capacitance	—	2480	—	pF	$\text{V}_{\text{GS}} = 0\text{V}, \text{V}_{\text{DS}} = 25\text{V}$ $f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	370	—		
C_{rss}	Reverse Transfer Capacitance	—	73	—		

Source-Drain Diode Ratings and Characteristics

	Parameter	Min	Typ	Max	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	18*	A	
I_{SM}	Pulse Source Current (Body Diode) ①	—	—	72		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_j = 25^\circ\text{C}, I_S = 18\text{A}, \text{V}_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	—	300	ns	$T_j = 25^\circ\text{C}, I_F = 18\text{A}, dI/dt \leq 100\text{A}/\mu\text{s}$
Q_{RR}	Reverse Recovery Charge	—	—	2.3	μC	$\text{V}_{\text{DD}} \leq 25\text{V}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.				

* Current is limited by package

Thermal Resistance

	Parameter	Min	Typ	Max	Units	Test Conditions
R_{thJC}	Junction-to-Case	—	—	1.25	$^\circ\text{C}/\text{W}$	

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

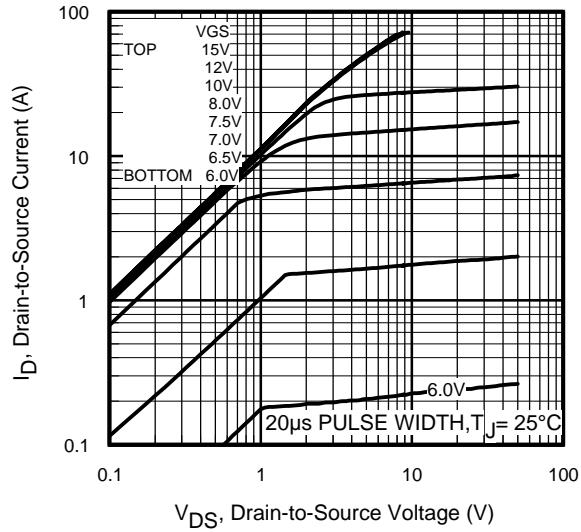


Fig 1. Typical Output Characteristics

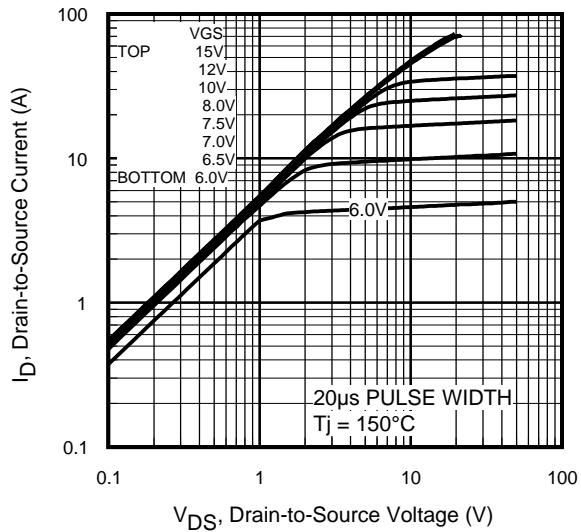


Fig 2. Typical Output Characteristics

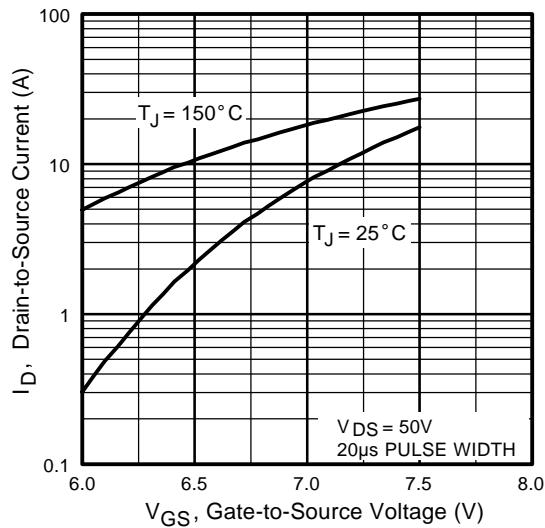


Fig 3. Typical Transfer Characteristics

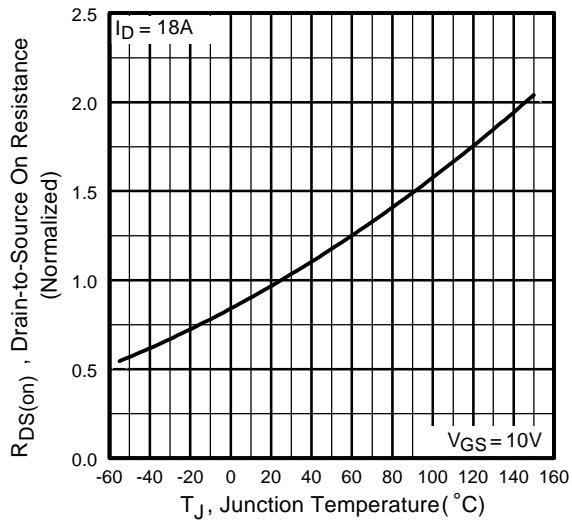
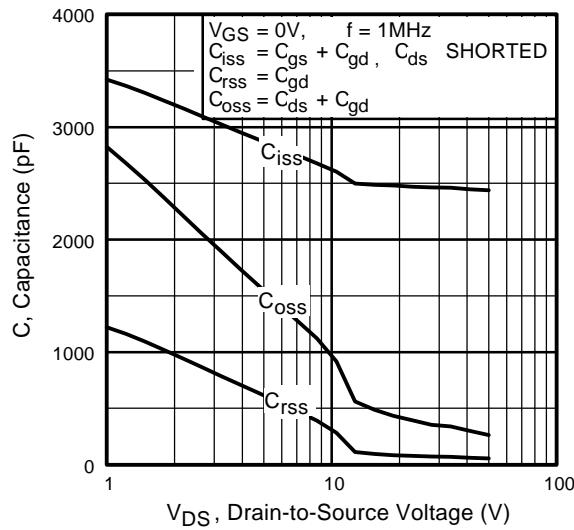
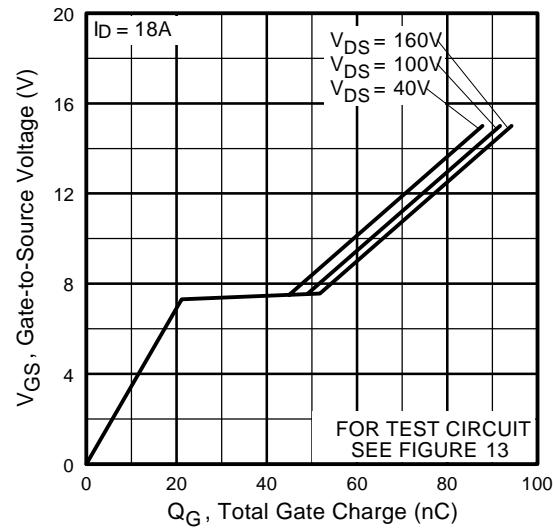
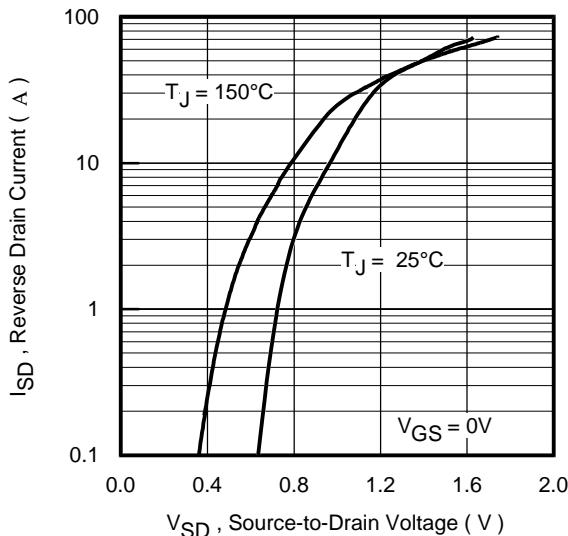
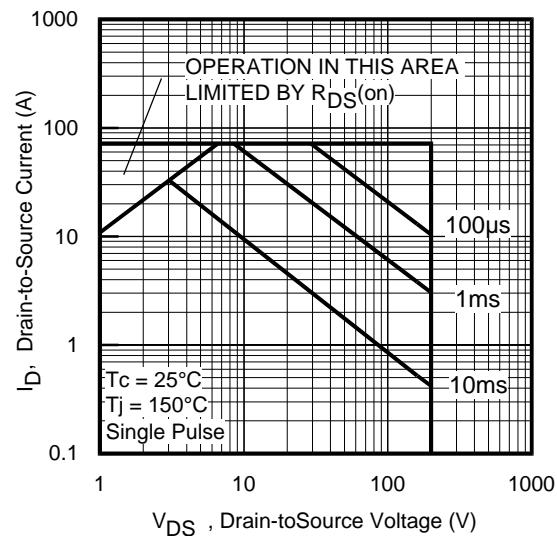


Fig 4. Normalized On-Resistance
Vs. Temperature

**Fig 5.** Typical Capacitance Vs.
Drain-to-Source Voltage**Fig 6.** Typical Gate Charge Vs.
Gate-to-Source Voltage**Fig 7.** Typical Source-Drain Diode
Forward Voltage**Fig 8.** Maximum Safe Operating Area

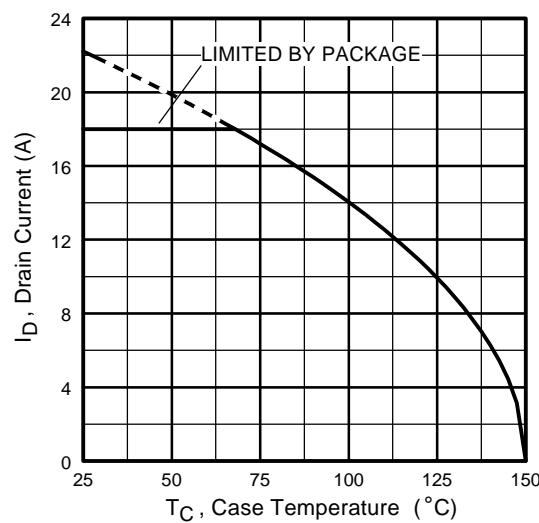


Fig 9. Maximum Drain Current Vs.
Case Temperature

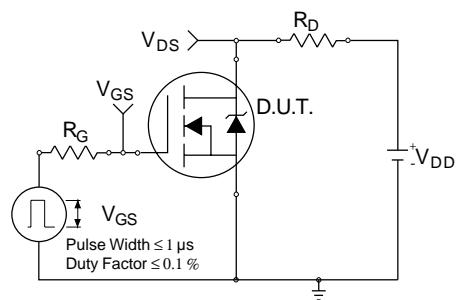


Fig 10a. Switching Time Test Circuit

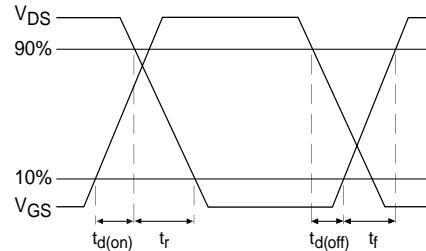


Fig 10b. Switching Time Waveforms

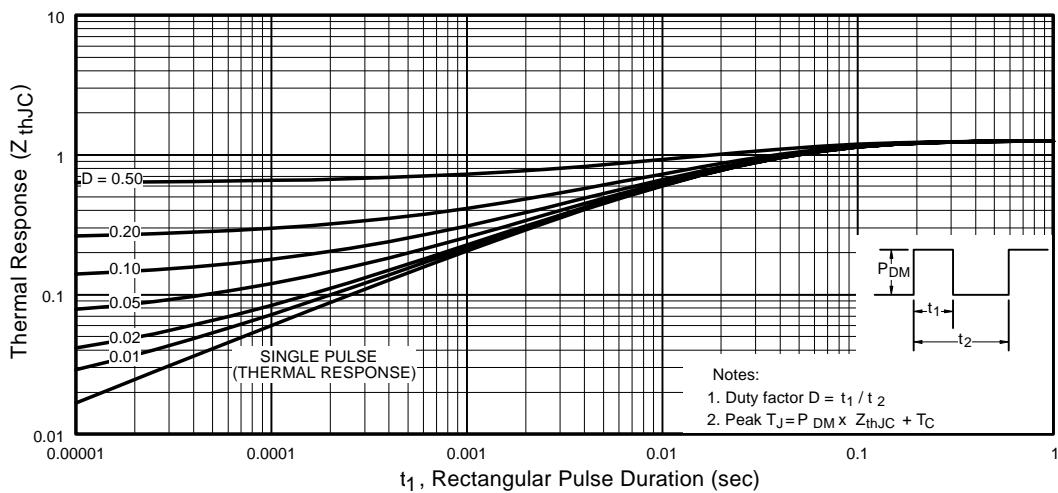


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

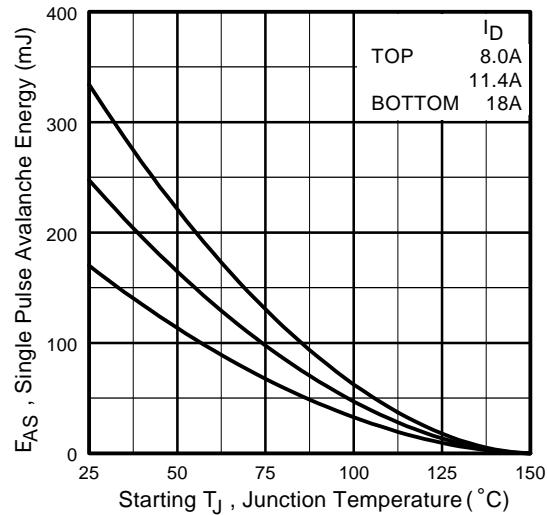
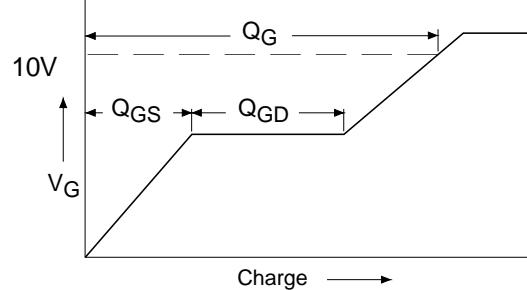
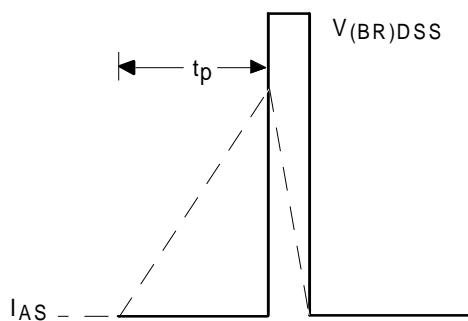
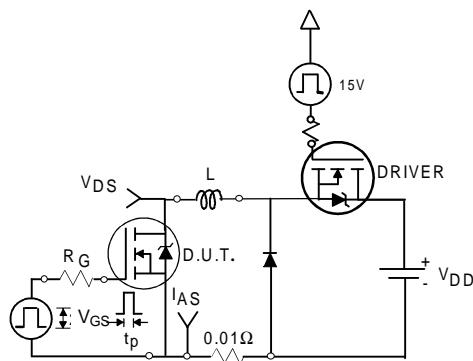
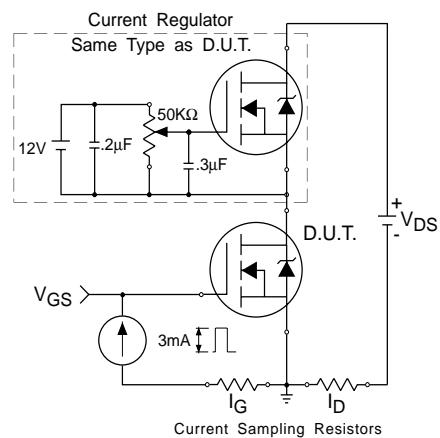


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

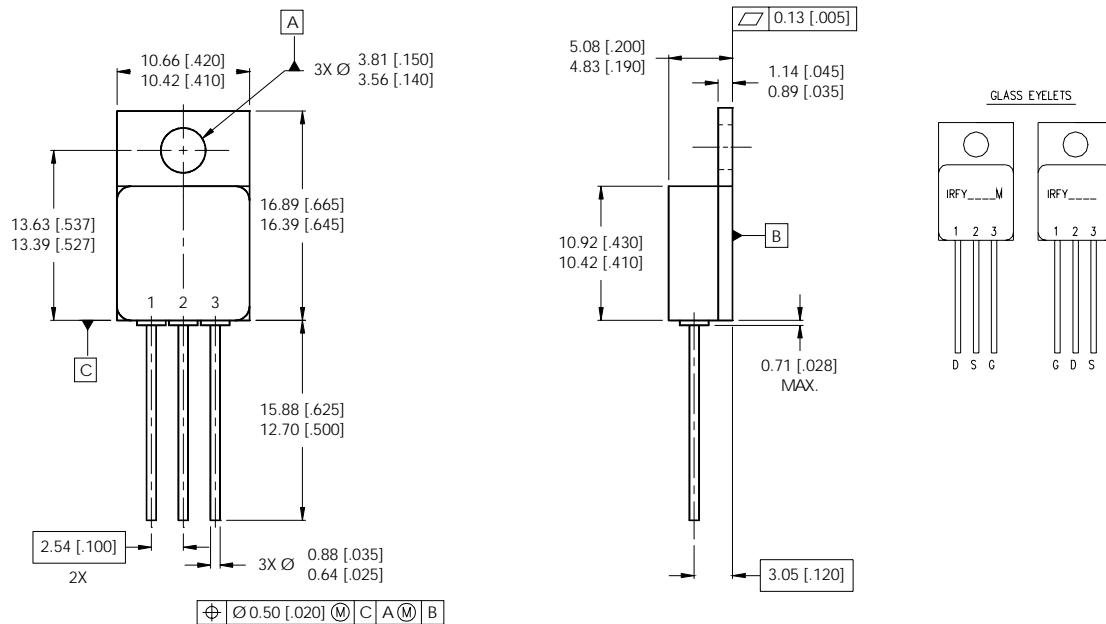


Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② V_{DD} = 25 V, Starting T_J = 25°C, L = 1.0 mH Peak I_{AS} = 18A, V_{GS} = 10V, R_G = 25Ω

- ③ I_{SD} ≤ 18A, di/dt ≤ 100 A/μs,
V_{DD} ≤ 200V, T_J ≤ 150°C
- ④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%

Case Outline and Dimensions — TO-257AA



NOTES:

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE TO-257AA.

PIN ASSIGNMENTS

- | | |
|---|----------|
| 1 | = GATE |
| 2 | = DRAIN |
| 3 | = SOURCE |

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.
Data and specifications subject to change without notice. 01/02